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Atty. Docket No. 20455-20338.00

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of: Robert DWILINSKI et al.

Serial No.: Not yet assigned

Filing Date: Concurrently herewith

For: PHOSPHOR SINGLE CRYSTAL SUBSTRATE AND METHOD FOR PREPARING THE SAME, AND NITRIDE SEMICONDUCTOR DEVICE

USING THE SAME

Examiner: Not Yet Assigned

Group Art Unit: N/A

## INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. § 1.97 & 1.98

MS Amendment Commissioner for Patents P.O. Box 1450 Alexandria, Virginia 22313-1450

Dear Sir:

Pursuant to 37 C.F.R. §1.97 and § 1.98, Applicants submit for consideration in the above-identified application the documents listed on the attached Form PTO/SB/08a/b. Copies of foreign documents and non-patent literature are submitted herewith. The Examiner is requested to make these documents of record.

va-84765

Application No.: Not yet assigned

Atty. Docket No. 20455-20338.00

The documents listed on the attached Form PTO/SB/08a/b were cited in an International Search Report mailed February 18, 2003, issued in PCT/IB02/04441; an International Search Report mailed February 18, 2003, issued in PCT/IB02/01136; an International Search Report mailed February 19, 2003, issued in PCT/IB02/04185; an International Search Report mailed April 8, 2003, issued in PCT/IP02/12969; an International Search Report mailed April 8, 2003, issued in PCT/IP02/13079; an International Search Report mailed April 8, 2003, issued in PCT/IP02/13079; an International Search Report mailed April 8, 2003, issued in PCT/IP02/12956; an International Search Report mailed April 16, 2003, issued in PCT/IP02/00077; a Preliminary Notice of Rejection of the IPO dated February 2, 2004, issued in Taiwan Patent Application No. 091110622; a Preliminary Examination Report mailed February 10, 2004, issued in PCT/IP02/11136; a Preliminary Notice of Rejection of the IPO dated August 30, 2004, issued in Taiwan Patent Application No. 091125039; a Notice of References Cited issued in U.S. Application No. 10/147,319; and a Notice of References Cited issued in U.S. Application No. 10/147,318 (copy attached).

This Information Disclosure Statement is submitted:

With the application; accordingly, no fee or separate requirements are required.

Applicants would appreciate the Examiner initialing and returning the Form PTO/SB/08a/b, indicating that the information has been considered and made of record herein.

The information contained in this Information Disclosure Statement under 37 C.F.R. § 1.97 and § 1.98 is not to be construed as a representation that: (i) a complete search has been made; (ii) additional information material to the examination of this application does not exist; (iii) the information, protocols, results and the like reported by third parties are accurate or enabling; or (iv) the above information constitutes prior art to the subject invention.

EFS-Web Receipt date: 11/16/2004

110/4314GA2:9881

Application No.: Not yet as

Atty. Docket No.

In the unlikely event that the transmittal form is separated from this document and the Patent Office determines that an extension and/or other relief (such as payment of a fee under 37 C.F.R. § 1.17 (p)) is required, Applicants petitions for any required relief including extensions of time and authorize the Commissioner to charge the cost of such petitions and/or other fees due in connection with the filing of this document to **Deposit Account No. 03-1952** referencing 204552033800.

Dated: November 16, 2004

Respectfully submitted

Barry E. Bretschneider

Registration No.: 28,055 MORRISON & FOERSTER LLP 1650 Tysons Blvd, Suite 300 McLean, Virginia 22102

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			First Named Inventor	Robert DWILINSKI		
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Sheet	1	of	2	Attorney Docket Number	204552033800	

			U.S. PA	TENT DOCUMENTS		
Examine		Document Number	Publication Date	Name of Patentee or	Pages, Columns, Lines, Whe Relevant Passages or Releva	
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\*EXAMINER: Initial if information considered, whether or not classion is in conformance with IMPED 500. There lies through classion if not in conformance and not considered, include copy of this form with meat commitmediation to applicant. "Applicant include basis in empirior, marker (proprior). See Kinth Codere conformation of the conformation

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s				First Named Inventor	Robert DWILINSKI	
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	(Use as many sheets as necessary)			Examiner Name	Not Yet Assigned	
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		NON PATENT LITERATURE DOCUMENTS	
xaminer nitials	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-lesue number(s), publisher, city and/or country where published.	T <sup>2</sup>
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\*EXAMINER: Initial If information considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

'Applicant's unique citation designation number (optional). <sup>2</sup>Applicant is to place a check mark here if English language Translation is attached.